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PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of

Docket No: Q91474

Hideyuki OHTAKE, et al.

Appln. No.: Based on PCT/JP04/012613

Confirmation No.: Not yet assigned

Group Art Unit: Not yet assigned

Filed: February 27, 2006

Examiner: Not yet assigned

For: **ELECTRIC-FIELD DISTRIBUTION MEASUREMENT METHOD AND APPARATUS
FOR SEMICONDUCTOR DEVICE**

INFORMATION DISCLOSURE STATEMENT
UNDER 37 C.F.R. §§ 1.97 and 1.98

MAIL STOP AMENDMENT

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

Sir:

In accordance with the duty of disclosure under 37 C.F.R. § 1.56, Applicant hereby notifies the U.S. Patent and Trademark Office of the documents which are listed on the attached PTO/SB/08 A & B (modified) form and/or listed herein and which the Examiner may deem material to patentability of the claims of the above-identified application.

One copy of each of the listed documents is submitted herewith, except for the following: U.S. patents and/or U.S. patent publications; and co-pending non-provisional U.S. applications filed after June 30, 2003.

The present Information Disclosure Statement is being filed: (1) No later than three months from the application's filing date; (2) Before the mailing date of the first Office Action on the merits (whichever is later); or (3) Before the mailing date of the first Office Action after

17 FEB 2006

INFORMATION DISCLOSURE STATEMENT

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filings a request for continued examination (RCE) under §1.114, and therefore, no Statement under 37 C.F.R. § 1.97(e) or fee under 37 C.F.R. § 1.17(p) is required.

In compliance with the concise explanation requirement under 37 C.F.R. § 1.98(a)(3) for foreign language documents, Applicant encloses herewith a copy of a Communication from a foreign patent office in a counterpart application citing such documents (International Search Report for PCT/JP04/012613 dated November 9, 2004), together with an English-language version (if not already included) of at least that portion of the Communication indicating the degree of relevance found by the foreign patent office.

The submission of the listed documents is not intended as an admission that any such document constitutes prior art against the claims of the present application. Applicant does not waive any right to take any action that would be appropriate to antedate or otherwise remove any listed document as a competent reference against the claims of the present application.

The USPTO is directed and authorized to charge all required fees, except for the Issue Fee and the Publication Fee, to Deposit Account No. 19-4880. Please also credit any overpayments to said Deposit Account.

Respectfully submitted,



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WASHINGTON OFFICE
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Date: February 27, 2006

Substitute for Form 1449 A & B/PTO		<i>Complete if Known</i>	
<u>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</u>		Application Number	Based on PCT/JP04/012613
(use as many sheets as necessary)		Confirmation Number	Not yet assigned 796
		Filing Date	February 27, 2006
		First Named Inventor	Hideyuki OHTAKE
		Art Unit	Not yet assigned
		Examiner Name	Not yet assigned
Sheet	1	of	1
		Attorney Docket Number	
		Q91474	

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city, and/or country where published.	Translation ⁶
		KIYOMI SAKAI, "Terahertz Time-Domain Spectroscopy", Bunko Kenkyu, pp. 261-273, 2001, Vol. 50, No. 6	
		T. KIWA, et al., "Backscattered THz Imaging for Extended Abstracts (The 50 th Spring Meeting)", pp. 1183, March 27, 2003, Vol. 3	
		DAVID J. AUTSON, et al., "Electrooptic Generation and Detection of Femtosecond Electrical Transients", IEEE Journal of Quantum Electronics, pp. 184-197, February 1988, Vol. 24, No. 2	

Examiner Signature _____ **Date Considered** _____

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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